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1 High-speed data acquisition and digital signal Processing system for PET imaging techniques applied to mammography

Martinez, J.D.; Benlloch, J.M.; Cerdà, J.; Lerche, Ch.W.; Pavón, I; Sebastià, A.;

Nuclear Science, IEEE Transactions on, Volume: 51, Issue: 3,] 2004

Pages:407 - 412

[\[Abstract\]](#) [\[PDF Full-Text \(136 KB\)\]](#) **IEEE JNL**

2 Decoupled control and DSP implement of PWM rectifier

Yanping Zhong; Songhua Shen;

Intelligent Control and Automation, 2004. WCICA 2004. Fifth World Congress on, Volume: 6, 15-19 June 2004

Pages:5199 - 5202 Vol.6

[\[Abstract\]](#) [\[PDF Full-Text \(294 KB\)\]](#) **IEEE CNF**

3 Scheduling for VoIP service in cdma2000 1x EV-DO

Young-June Choi; Saewoong Bahk;

Communications, 2004 IEEE International Conference on, Volume: 3, 20-24 June 2004

Pages:1495 - 1499 Vol.3